1200V 80mohm Silicon Carbide Power MOSFET
AKCK2M080WAMH

Features:

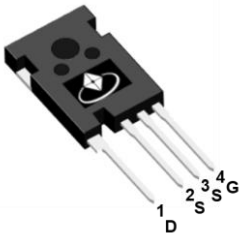
- High blocking voltage with low $R_{DS(ON)}$
- Fast switching speed with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{RR})
- Halogen-free，RoHS compliant (Note 1)

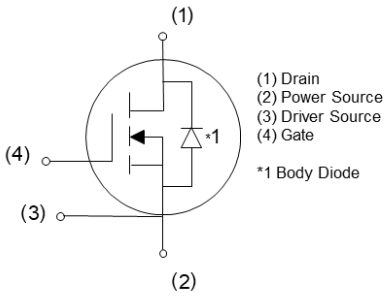
Applications:

- PFC
- EV battery charges
- High voltage DC/DC converters
- Booster converters
- Solar inverters

Key Performance Parameters:

Parameter	Value	Unit
V_{DS}	1200	V
$R_{DSON,\ TYP}$ @V_{GS} = 18 V	80	mΩ
I_D	35	A
P_D	187	W





Ordering Information:

Ordering Code	Package Type	Marking Code	Form	Packing
AKCK2M080WAMH	TO-247-4L	CK2M080WAMH	Tube	450 per box

Notes:

1. Contact ALKAIDSEMI sales for detail information

Maximum Ratings (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Value	Units
V_{DS}	Drain-Source Voltage	1200	V
I_D	Drain Current - Continuous (T_C = 25°C) (Note 1)	35	A
	Drain Current - Continuous (T_C = 100°C) (Note 1)	25	A
I_{DM}	Drain Current - Pulsed (Note 2)	80	A
V_{GS}	Gate-Source Voltage (dynamic)	-10/+22	V
V_{GS}	Gate-Source Voltage (static)	-6/+18	V
P_D	Power Dissipation (T_C = 25°C)	187	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +175	°C

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Steady-State	0.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Steady-State	40	°C/W

Notes:

1. The max drain current limited by maximum junction temperature
2. Repetitive Rating: Pulse width limited by maximum junction temperature

Electrical Characteristics (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 100 μA	1200			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 1200 V, V_{GS} = 0 V		5	50	μA
I_{GSS}	Gate Leakage Current	V_{GS} = + 18 V, V_{DS} = 0 V			100	nA
		V_{GS} = - 6 V, V_{DS} = 0 V			100	nA
$V_{GS(TH)}$	Gate Threshold voltage	V_{DS} = V_{GS}, I_D = 5 mA	2.2	3.2	4.5	V
		V_{DS} = V_{GS}, I_D = 5 mA, T_J = 175 °C		2.2		V
$R_{DS(ON)}$	Drain-Source on-state resistance	V_{GS} = 18 V, I_D = 20 A		80	95	mΩ
		V_{GS} = 18 V, I_D = 20 A, T_J = 175 °C		128		mΩ
G_{FS}	Forward Transconductance	V_{DS} = 20 V, I_D = 20 A		11		S
		V_{DS} = 20 V, I_D = 20 A, T_J = 175 °C		9.5		S
Dynamic Characteristics						
C_{ISS}	Input Capacitance	V_{DS} = 800 V, V_{GS} = 0 V, F = 100 kHz, V_{AC} = 25 mV		1295		pF
C_{OSS}	Output Capacitance			65		pF
C_{RSS}	Reverse Transfer Capacitance			8		pF
E_{OSS}	C_{OSS} Stored Energy			26		μJ
R_G	Gate Resistance	F = 1 MHz, V_{AC} = 25 mV		5.4		Ω
Q_{GS}	Gate-Source Charge	V_{DS} = 800 V , I_D = 20 A, V_{GS} = -5/+18 V		17		nC
Q_{GD}	Gate-Drain Charge			36		nC
Q_G	Total Gate Charge			68.6		nC

Switching Characteristics (NOTE3)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$T_{D(ON)}$	Turn On Delay Time	V_{DD} = 800 V , I_D = 20 A, V_{GS} = -5/+18 V, $R_{G,EXT}$ = 5 Ω L = 99 μH Diode： Body Diode at V_{GS} = -5V		14		nS
T_R	Rise Time			10		nS
$T_{D(OFF)}$	Turn Off Delay Time			21		nS
T_F	Fall Time			17		nS
E_{ON}	Turn On Energy			625		μJ
E_{OFF}	Turn Off Energy			57		μJ
$T_{D(ON)}$	Turn On Delay Time	V_{DD} = 800 V , I_D = 20 A, V_{GS} = -5/+18 V, $R_{G,EXT}$ = 5 Ω L = 99 μH Diode： Body Diode at V_{GS} = -5V T_J = 175 °C		13		nS
T_R	Rise Time			8		nS
$T_{D(OFF)}$	Turn Off Delay Time			23		nS
T_F	Fall Time			15		nS
E_{ON}	Turn On Energy			579		μJ
E_{OFF}	Turn Off Energy			54		μJ

Note3: All switching charateristics reference TO247-3L.

Drain-Source Diode Characteristics (T_J = 25 °C unless otherwise noted)

I_S	Maximum Continuous Drain-Source Diode Forward Current			35		A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current			80		A
V_{SD}	Diode Forward Voltage	V_{GS} = -4 V , I_{SD} = 20 A		5		V
		V_{GS} = -4 V , I_{SD} = 20 A, T_J = 175 °C		3.4		V
I_{RM}	Peak Reverse Recovery Current	V_{GS} = -4 V , I_{SD} = 20 A, V_R = 800 V, di/dt = 460 A/μS		5		A
T_{RR}	Reverse Recovery Time			17		nS
Q_{RR}	Reverse Recovery Charge			44		nC

Electrical Characteristics Diagrams(Note4)

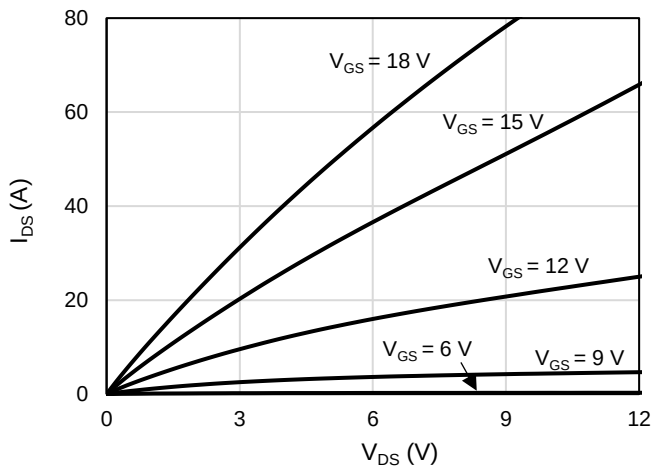


Figure 1: Output Characteristics T_J = -40℃

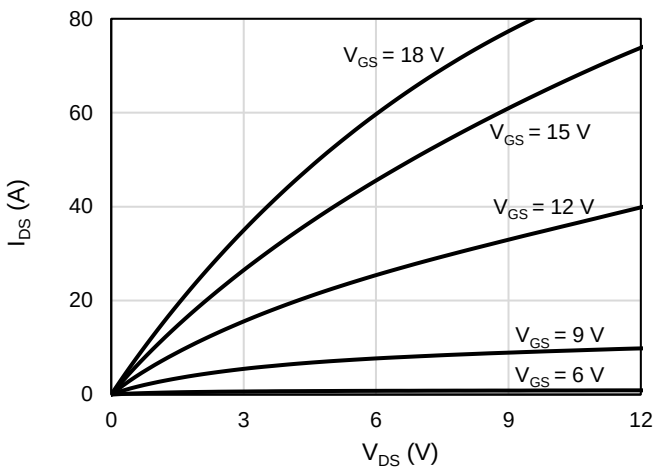


Figure 2: Output Characteristics T_J = 25℃

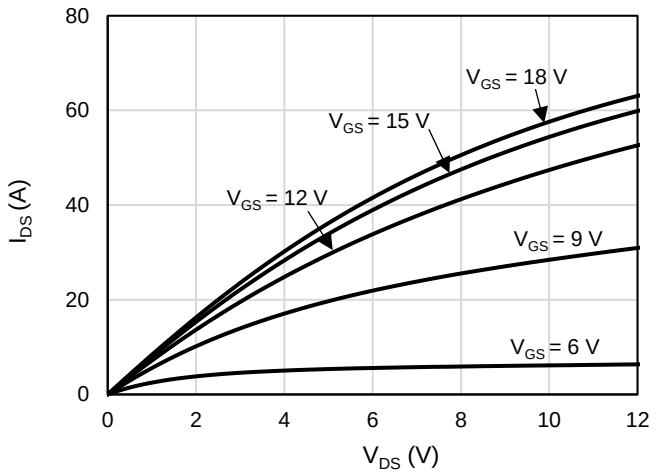


Figure 3: Output Characteristics T_J = 175℃

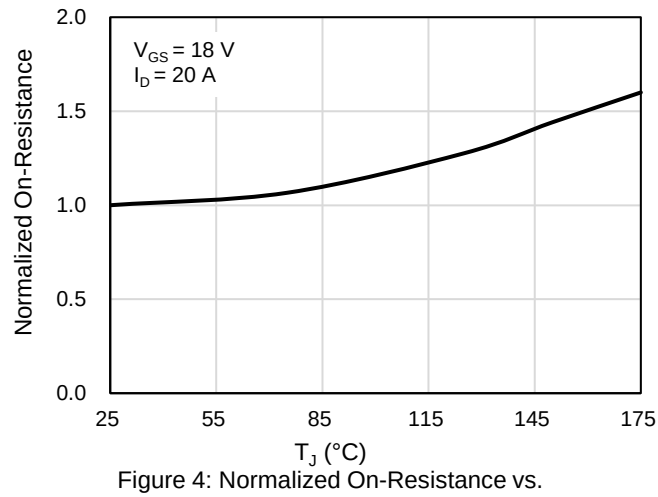


Figure 4: Normalized On-Resistance vs. Temperature

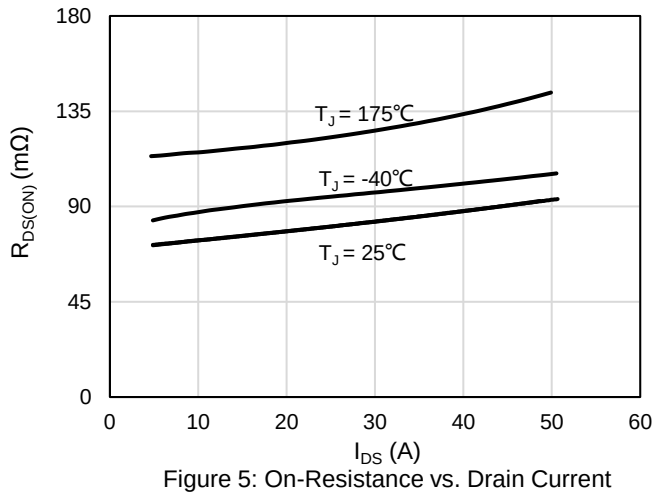


Figure 5: On-Resistance vs. Drain Current For Various Temperatures

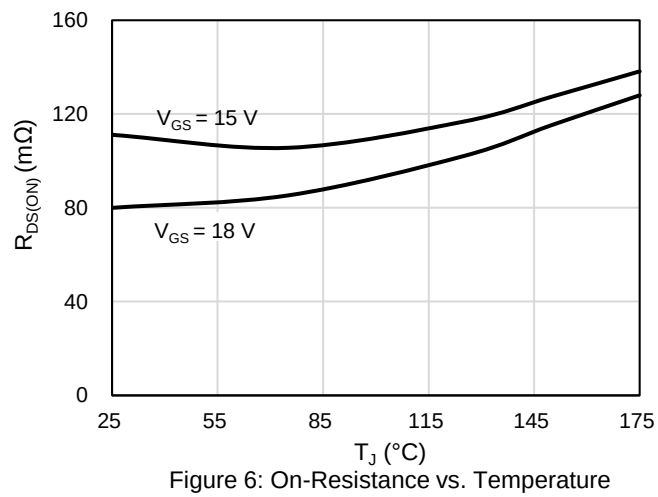


Figure 6: On-Resistance vs. Temperature For Various Gate Voltage

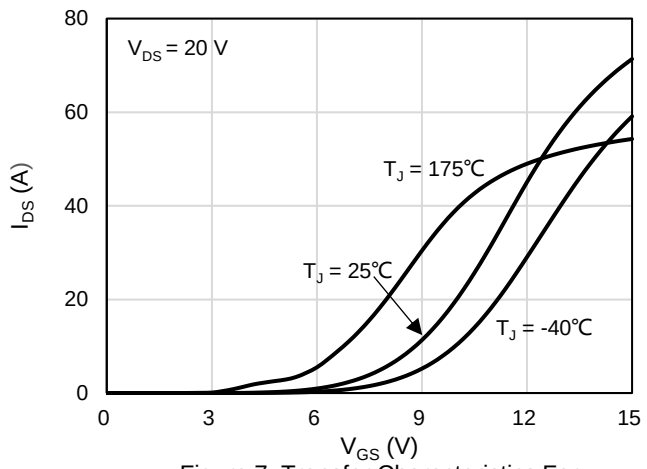


Figure 7: Transfer Characteristics For Various Junction Temparature

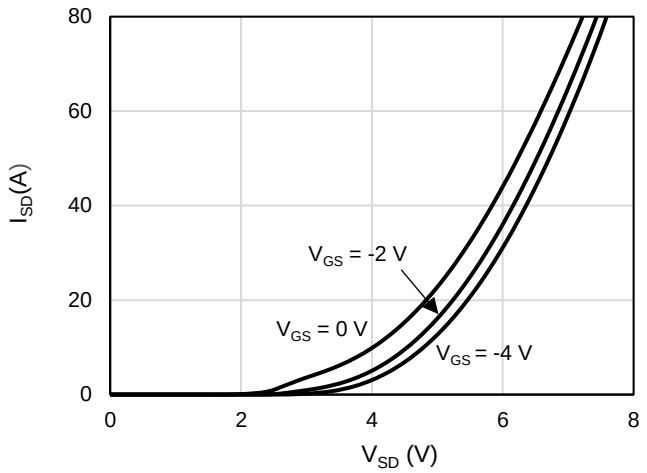


Figure 8: Body Diode Characteristics at -40℃

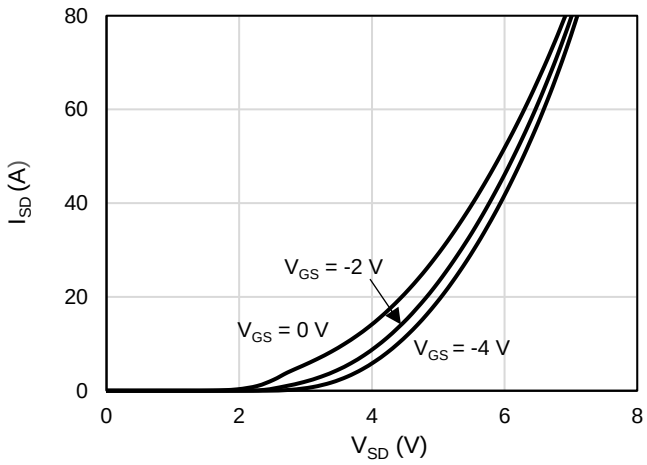


Figure 9: Body Diode Characteristics at 25℃

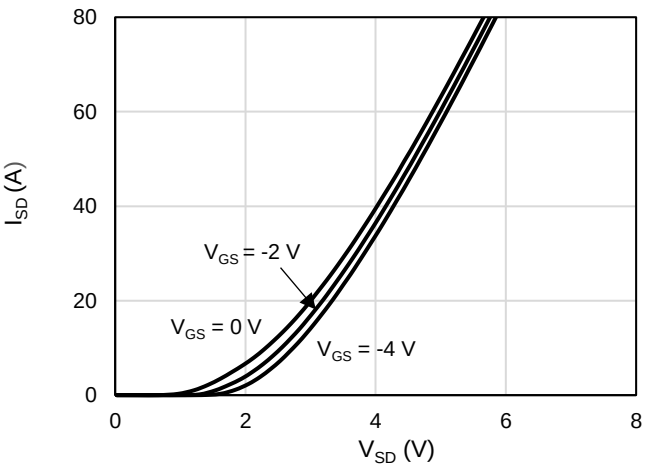


Figure 10: Body Diode Characteristics at 175℃

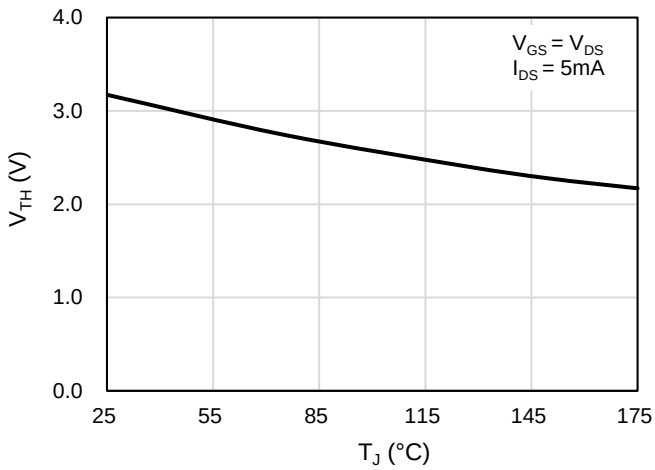


Figure 11: Threshold Voltage vs. Temperature

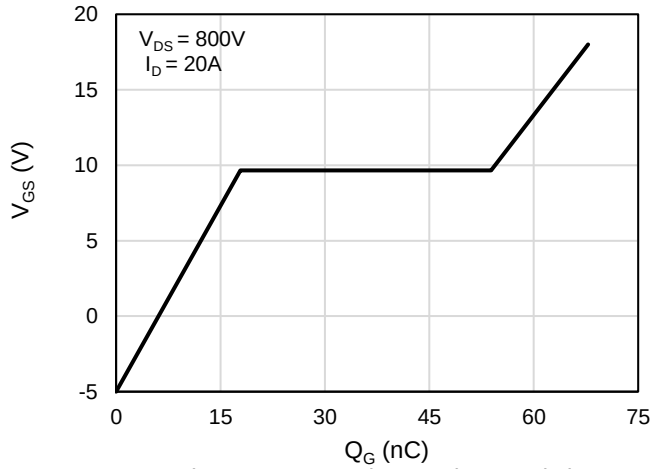


Figure 12: Gate-Charge Characteristics

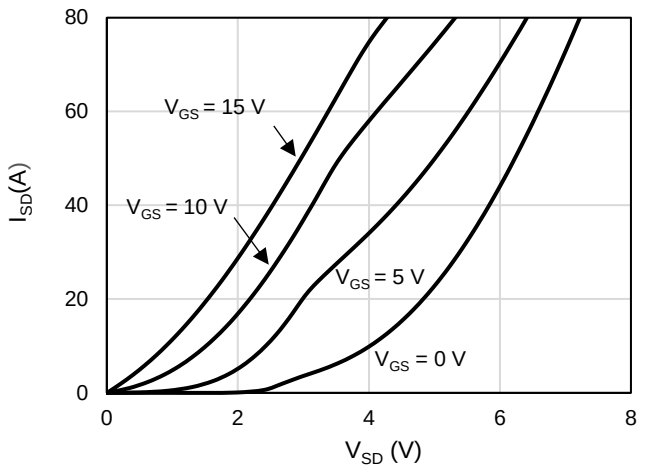


Figure 13: 3rd Quadrant Characteristics at -40℃

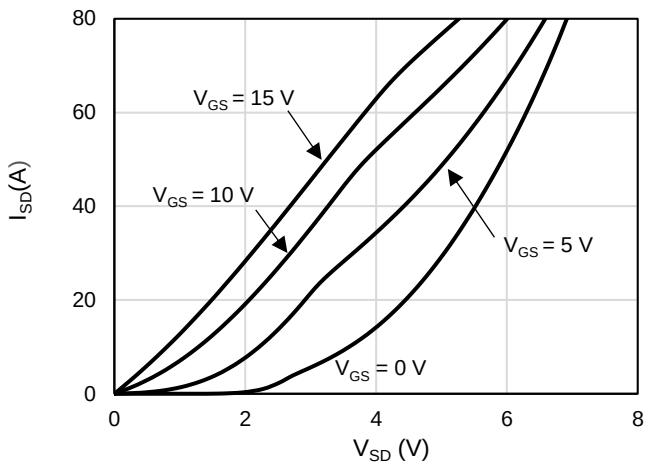


Figure 14: 3rd Quadrant Characteristics at 25℃

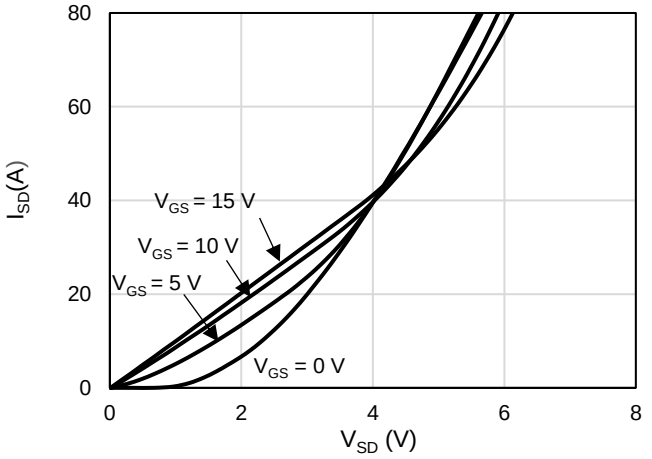


Figure 15: 3rd Quadrant Characteristics at 175℃

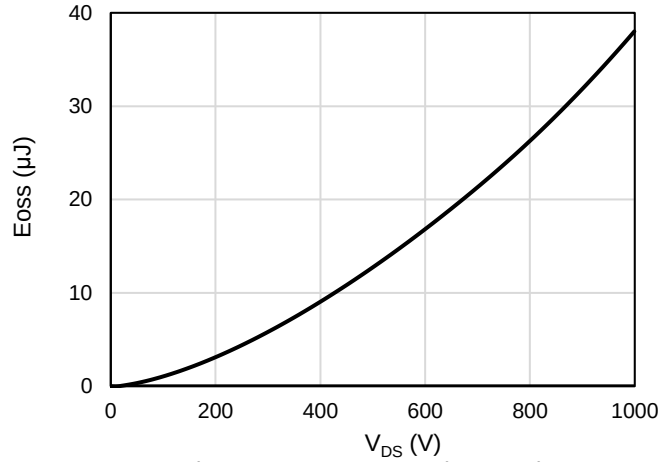


Figure 16: Output Capacitor Stord Energy

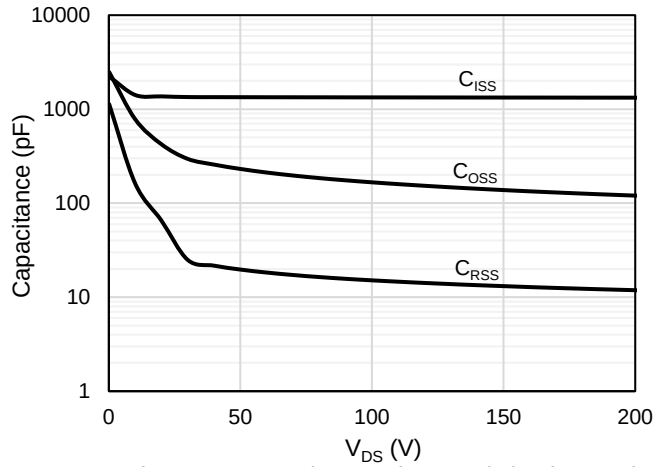


Figure 17: Capacitance Characteristics (0-200V)

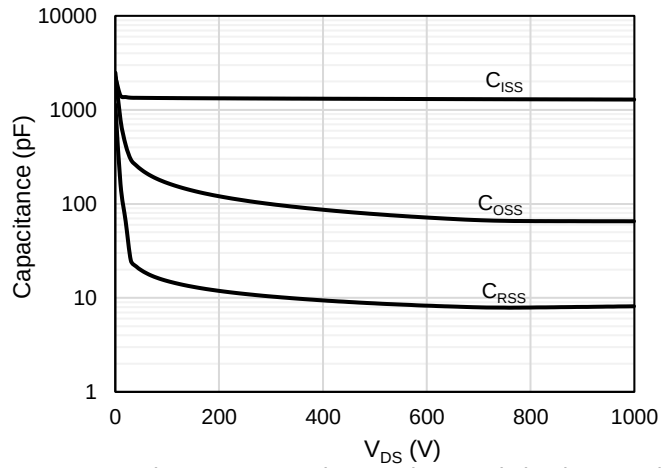


Figure 18: Capacitance Characteristics (0-1200V)

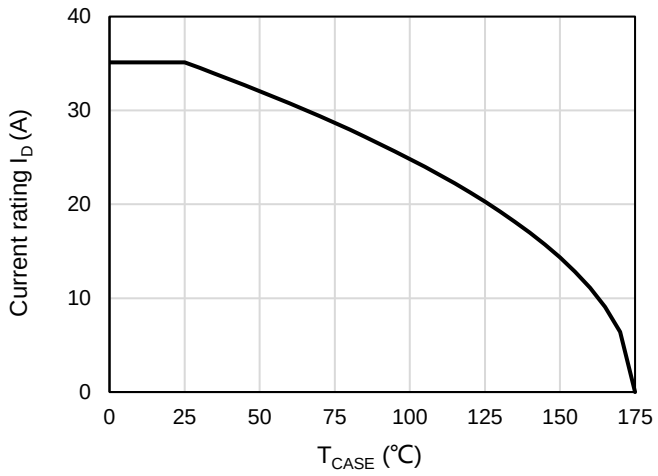


Figure 19: Current De-rating

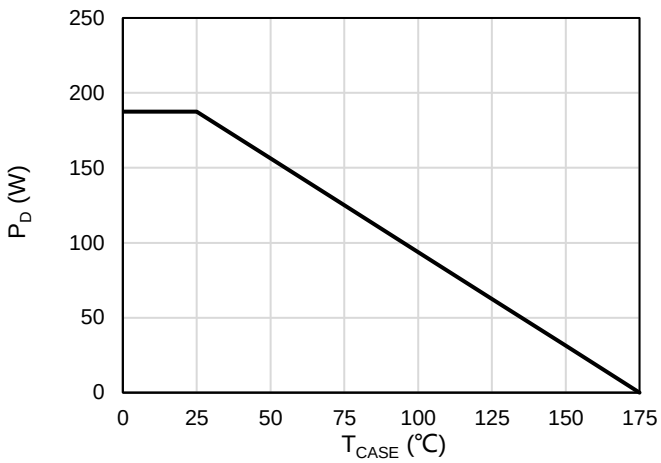


Figure 20: Maximum Power Disspation Derating vs CaseTemperature

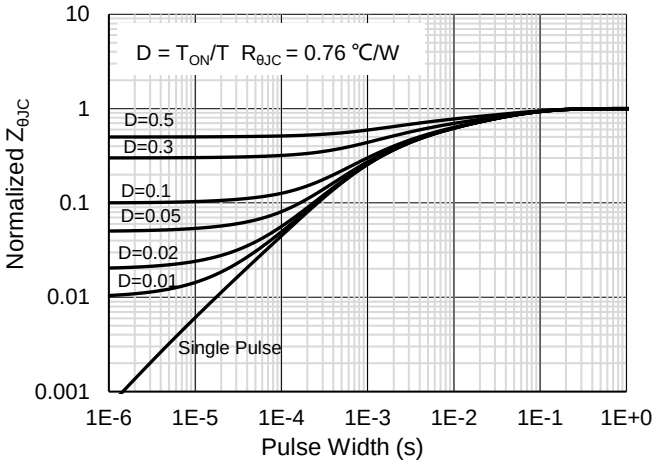


Figure 21: Normalized Maximum Transient Thermal Impedance

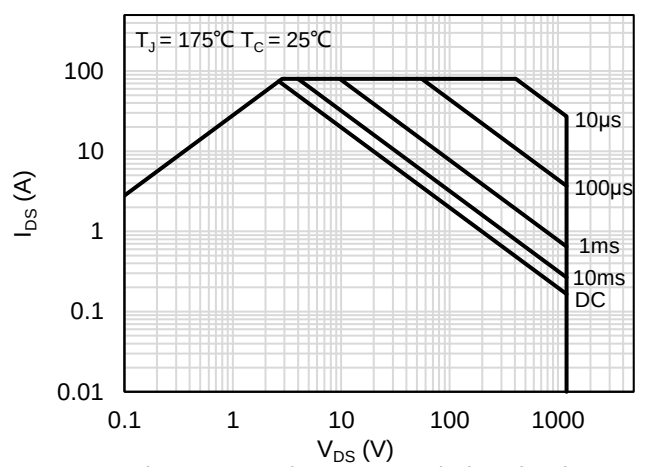


Figure 22: Maximum Forward Biased Safe Operating Area

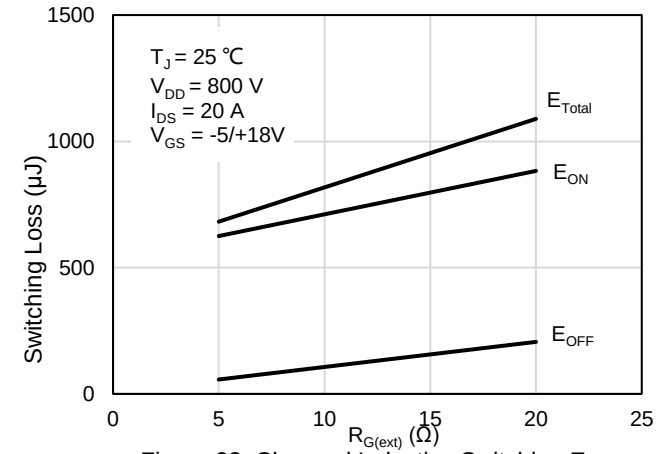


Figure 23: Clamped Inductive Switching Energy vs. $R_{G(ext)}$

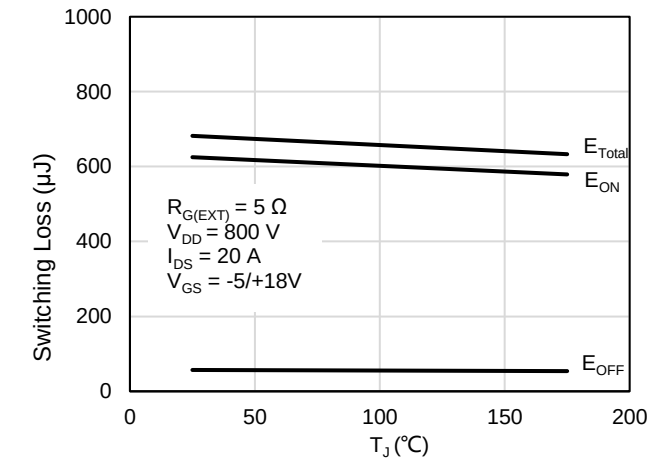


Figure 24: Clamped Inductive Switching Energy vs. T_J

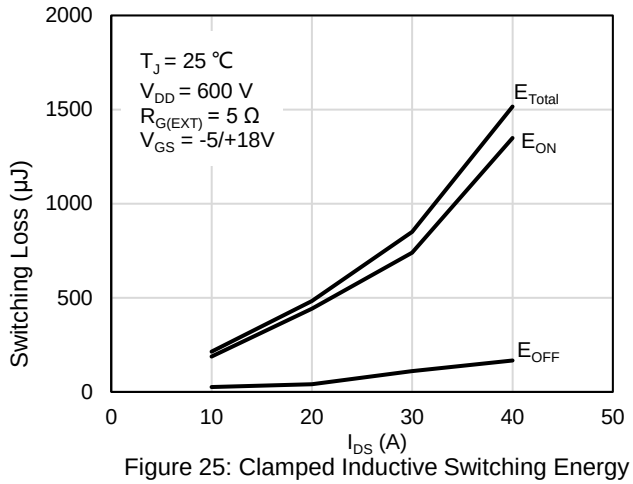


Figure 25: Clamped Inductive Switching Energy vs. Drain Current (V_{DD} = 600 V)

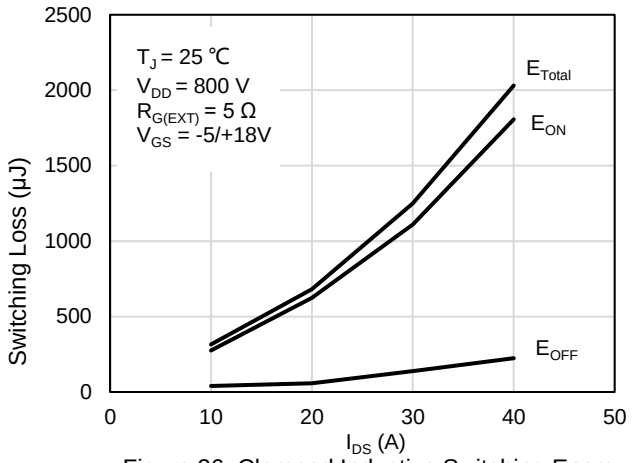
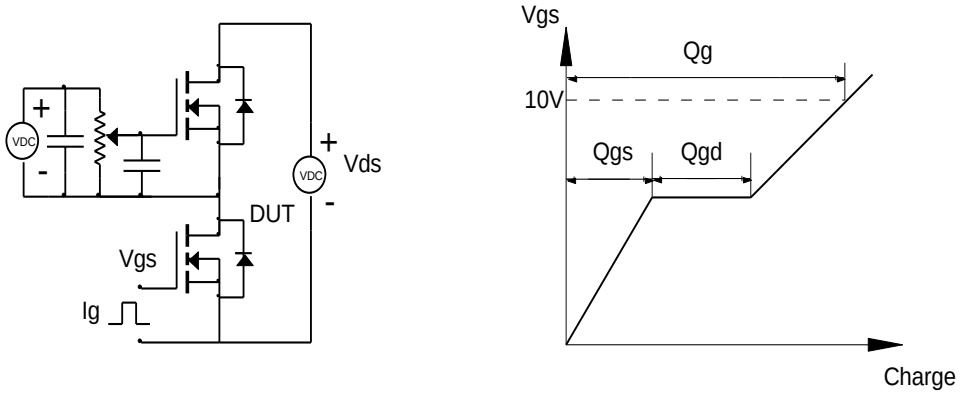


Figure 26: Clamped Inductive Switching Energy vs. Drain Current (V_{DD} = 800 V)

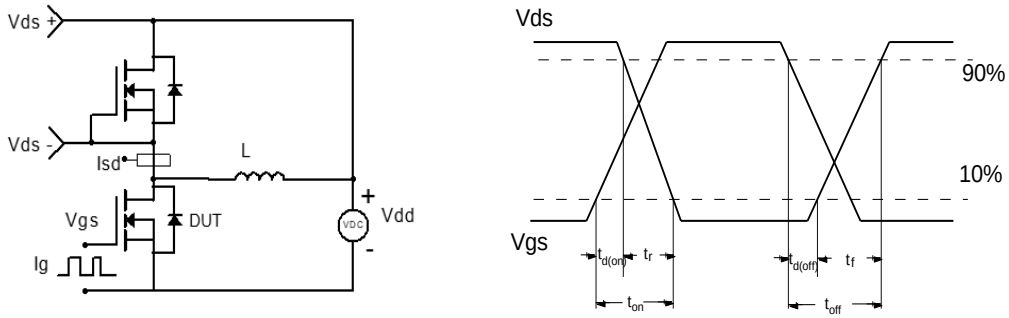
Note4: All figures reference TO247-3L.

Test Circuit and Waveform

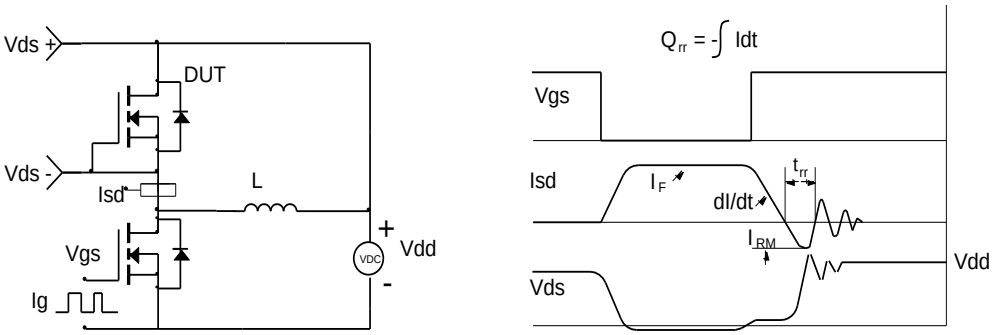
Gate Charge Test Circuit & Waveform



Clamped Inductive Switching Test Circuit & Waveforms

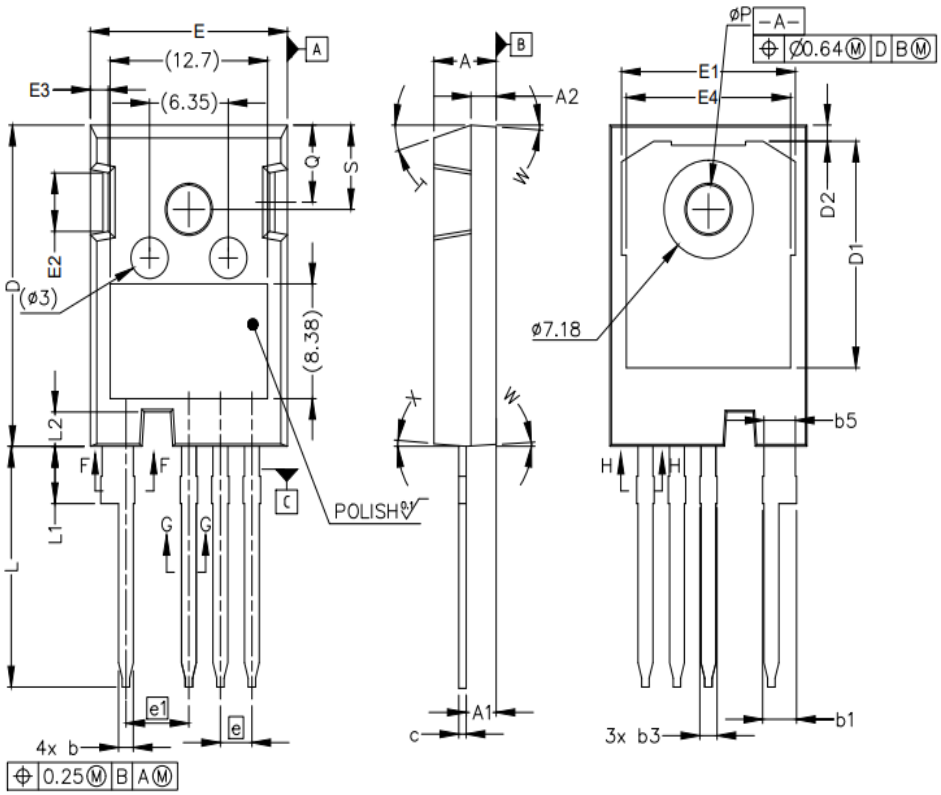


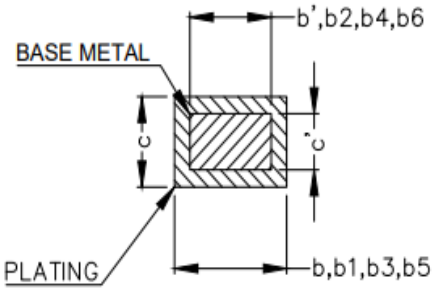
Diode Recovery Test Circuit & Waveforms



Package Outlines

TO-247-4L PKG Outlines





SECTION "F-F", "G-G" AND "H-H"
SCALE: NONE

SYMBOL	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b'	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
c'	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
øP	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5 ° REF.	
X	4° REF.	

Marking Information

Note:

CK2M080WAMH = Product Name Code

XXXXXXX = Date Code

Contact ALKAIDSEMI sales for detail information

Revision History		
Revision	Release Date	Remark
Rev.1.5	2022/9/2	

Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Alkaidsemi assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.